Econometrics 2 - Lecture 3

Univariate Time Series Models

Contents

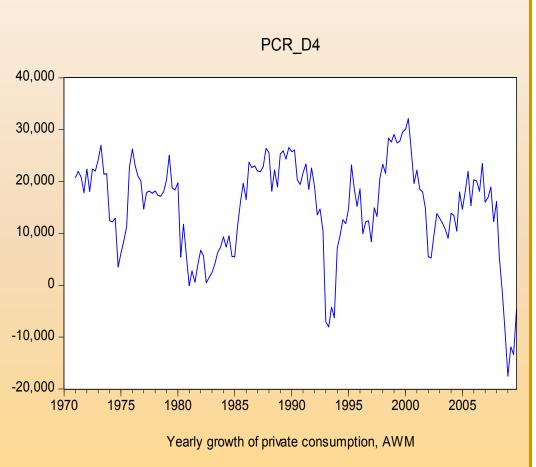
- Time Series
- Stochastic Processes
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- The ARMA Process
- Deterministic and Stochastic Trends
- Models with Trend
- Unit Root Tests
- Estimation of ARMA Models

Private Consumption

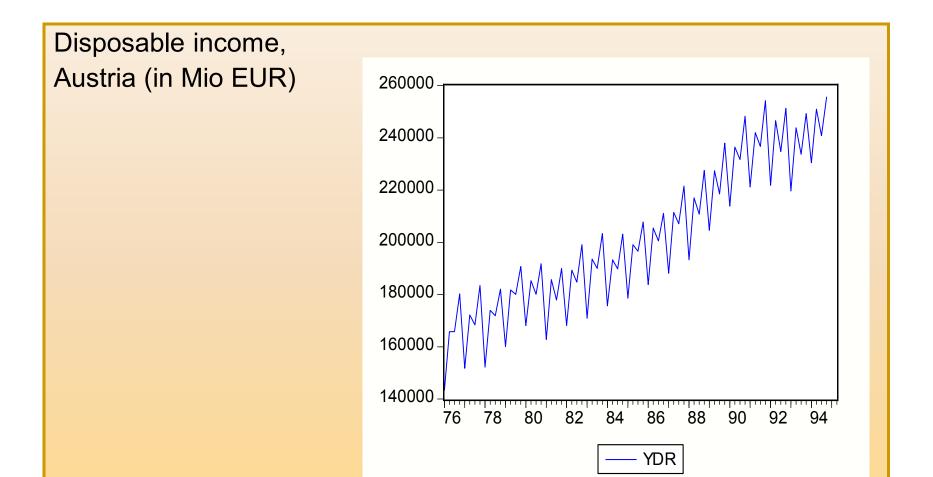
Private consumption in the EURO area (16 mem-**PCR** bers), quarterly data, 1,100,000 seasonally adjusted, 1,000,000 AWM database (in 900,000 MioEUR) 800,000 700,000 600,000 500,000 400,000 300,000 1980 1985 1990 2000 1975 1995 2005 Private Consumption in MioEUR, quaterly data, AWM

Private Consumption: Growth Rate

Yearly growth of private consumption in EURO area (16 members), AWM database (in MioEUR)
Mean growth: 15.008



Disposable Income



Time Series

Time-ordered sequence of observations of a random variable

Examples:

- Annual values of private consumption
- Yearly changes in expenditures on private consumption
- Quarterly values of personal disposable income
- Monthly values of imports

Notation:

- Random variable Y
- Sequence of observations $Y_1, Y_2, ..., Y_T$
- Deviations from the mean: $y_t = Y_t E\{Y_t\} = Y_t \mu$

Components of a Time Series

Components or characteristics of a time series are

- Trend
- Seasonality
- Irregular fluctuations

Time series model: represents the characteristics as well as possible interactions

Purpose of modelling

- Description of the time series
- Forecasting the future

Example: Quarterly observations of the disposable income

$$Y_t = \beta t + \sum_i \gamma_i D_{it} + \varepsilon_t$$

with $D_{it} = 1$ if t corresponds to i-th quarter, $D_{it} = 0$ otherwise

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Stochastic Process

Time series: realization of a stochastic process

Stochastic process is a sequence of random variables Y_t , e.g.,

$$\{Y_t, t = 1, ..., n\}$$

 $\{Y_t, t = -\infty, ..., \infty\}$

Joint distribution of the Y_1, \dots, Y_n :

$$p(y_1,, y_n)$$

Of special interest

- Evolution of the expectation $\mu_t = E\{Y_t\}$ over time
- Dependence structure over time

Example: Extrapolation of a time series as a tool for forecasting

White Noise

White noise process $\{Y_t, t = -\infty, ..., \infty\}$

- $E\{Y_t\} = 0$
- $V\{Y_t\} = \sigma^2$
- Cov $\{Y_t, Y_{t-s}\}$ = 0 for all (positive or negative) integers s i.e., a mean zero, serially uncorrelated, homoskedastic process

AR(1)-Process

States the dependence structure between consecutive observations as

$$Y_t = \delta + \theta Y_{t-1} + \varepsilon_t, \quad |\theta| < 1$$

with ε_t : white noise, i.e., $V\{\varepsilon_t\} = \sigma^2$ (see next slide)

Autoregressive process of order 1

From
$$Y_t = \delta + \theta Y_{t-1} + \epsilon_t = \delta + \theta \delta + \theta^2 \delta + ... + \epsilon_t + \theta \epsilon_{t-1} + \theta^2 \epsilon_{t-2} + ...$$
 follows $E\{Y_t\} = \mu = \delta(1-\theta)^{-1}$

 $|\theta|$ < 1 needed for convergence! Invertibility condition

In deviations from μ , $y_t = Y_t - \mu$:

$$y_t = \theta y_{t-1} + \varepsilon_t$$

AR(1)-Process, cont'd

Autocovariances $\gamma_k = \text{Cov}\{Y_t, Y_{t-k}\}$

- k=0: $\gamma_0 = V\{Y_t\} = \theta^2 V\{Y_{t-1}\} + V\{\varepsilon_t\} = \dots = \Sigma_i \theta^{2i} \sigma^2 = \sigma^2 (1-\theta^2)^{-1}$
- $k=1: \gamma_1 = \text{Cov}\{Y_t, Y_{t-1}\} = \text{E}\{y_t y_{t-1}\} = \text{E}\{(\theta y_{t-1} + \varepsilon_t) y_{t-1}\} = \theta \text{V}\{y_{t-1}\}$ = $\theta \sigma^2 (1 - \theta^2)^{-1}$
- In general:

$$\gamma_k = \text{Cov}\{Y_t, Y_{t-k}\} = \theta^k \sigma^2 (1-\theta^2)^{-1}, \ k = 0, 1, ...$$
 depends upon k , not upon $t!$

MA(1)-Process

States the dependence structure between consecutive observations as

$$Y_t = \mu + \varepsilon_t + \alpha \varepsilon_{t-1}$$

with ε_t : white noise, $V\{\varepsilon_t\} = \sigma^2$

Moving average process of order 1

$$E\{Y_t\} = \mu$$

Autocovariances $\gamma_k = \text{Cov}\{Y_t, Y_{t-k}\}$

- k=0: $\gamma_0 = V\{Y_t\} = \sigma^2(1+\alpha^2)$
- $k=1: \gamma_1 = \text{Cov}\{Y_t, Y_{t-1}\} = \alpha \sigma^2$
- $\mathbf{v}_{k} = 0 \text{ for } k = 2, 3, \dots$
- Depends upon k, not upon t!

AR-Representation of MA-Process

The AR(1) can be represented as MA-process of infinite order

$$y_t = \theta y_{t-1} + \varepsilon_t = \sum_{i=0}^{\infty} \theta^i \varepsilon_{t-i}$$

given that $|\theta| < 1$

Similarly: the AR representation of the MA(1) process

$$y_t = \alpha y_{t-1} - \alpha^2 y_{t-2} \quad \dots + \varepsilon_t = \sum_{i=0}^{\infty} (-1)^i \alpha^{i+1} y_{t-i-1} + \varepsilon_t$$
 given that $|\alpha| < 1$

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Stationary Processes

Refers to the joint distribution of Y_t 's, in particular to the second moments

(Weak) stationary or covariance stationary process: the first two moments are finite and not affected by a shift of time

A process is called strictly stationary if its stochastic properties are unaffected by a change of the time origin

 The joint probability distribution at any set of times is not affected by an arbitrary shift along the time axis

AC and PAC Function

Autocorrelation function (AC function, ACF) Independent of the scale of *Y*

For a stationary process:

$$\rho_{k} = \text{Corr}\{Y_{t}, Y_{t-k}\} = \gamma_{k}/\gamma_{0}, k = 0, 1, ...$$

- Properties:
 - $|\rho_k| \le 1$
 - $\rho_k = \rho_{-k}$
 - $\rho_0 = 1$
- Correlogram: graphical presentation of the AC function

Partial autocorrelation function (PAC function, PACF):

$$\theta_{kk} = \text{Corr}\{Y_t, Y_{t-k}|Y_{t-1},...,Y_{t-k+1}\}, k = 0, 1, ...$$

- θ_{kk} is obtained from $Y_t = \theta_{k0} + \theta_{k1}Y_{t-1} + ... + \theta_{kk}Y_{t-k}$
- Partial correlogram: graphical representation of the PAC function

Examples

for the AC and PAC functions:

White noise

$$\rho_0 = \theta_{00} = 1$$

$$\rho_k = \theta_{kk} = 0, \text{ if } k \neq 0$$

white noise is stationary

- AR(1) process, $Y_t = \delta + \theta Y_{t-1} + \epsilon_t$ $\rho_k = \theta^k$, k = 0, 1,... $\theta_{00} = 1, \theta_{11} = \theta, \theta_{kk} = 0$ for k > 1
- MA(1) process, $Y_t = \mu + \epsilon_t + \alpha \epsilon_{t-1}$ $\rho_0 = 1$, $\rho_1 = \alpha/(1 + \alpha^2)$, $\rho_k = 0$ for k > 1

PAC function: damped exponential if $\alpha > 0$, alternating and damped exponential if $\alpha < 0$

Stationarity of MA- and AR-Processes

MA processes are stationary

- Weighted sum of white noises
- E.g., MA(1) process: $Y_t = \mu + \epsilon_t + \alpha \epsilon_{t-1}$ $\rho_0 = 1$, $\rho_1 = \alpha/(1 + \alpha^2)$, $\rho_k = 0$ for k > 1

An AR process is stationary if it is invertible

AR(1) process, $Y_t = \theta Y_{t-1} + \epsilon_t = \sum_{i=0}^{\infty} \theta^i \epsilon_{t-i}$ if $|\theta| < 1$ (invertibility condition)

$$\rho_{k} = \theta^{k}, k = 0, 1,...$$

AC and PAC Function: Estimates

Estimator for the AC function ρ_k:

$$V_k = \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t \end{array}}_{T} \underbrace{\begin{array}{c} \mathcal{Y}_t & \mathcal{Y}_t \\ \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y}_t & \mathcal{Y$$

Estimator for the PAC function $θ_{kk}$: coefficient of Y_{t-k} in the regression of Y_t on Y_{t-1} , ..., Y_{t-k}

AR(1) Processes, Verbeek, Fig. 8.1

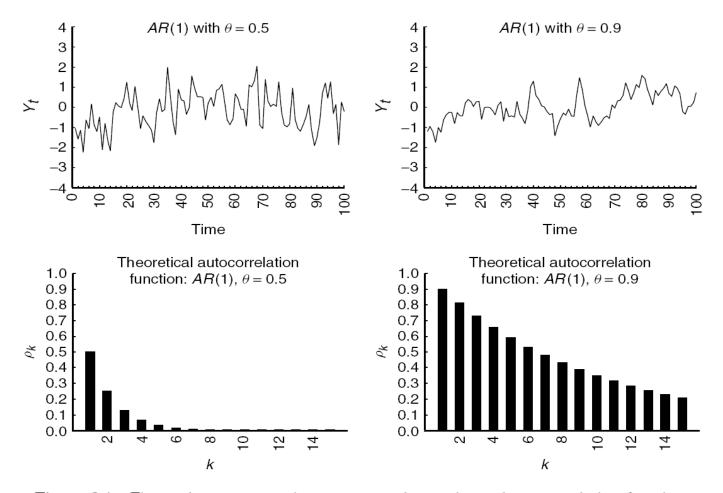


Figure 8.1 First-order autoregressive processes: data series and autocorrelation functions

MA(1) Processes, Verbeek, Fig. 8.2

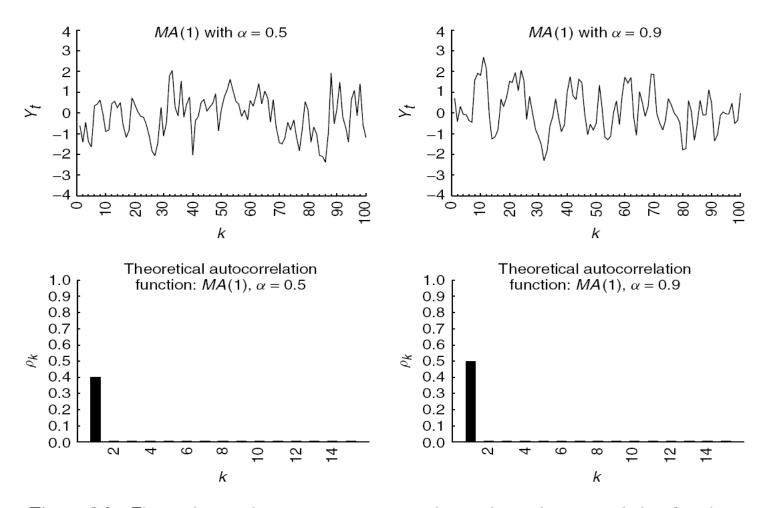


Figure 8.2 First-order moving average processes: data series and autocorrelation functions

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The ARMA(p,q) Process

Generalization of the AR and MA processes: ARMA(p,q) process

$$y_{t} = \theta_{1}y_{t-1} + \dots + \theta_{p}y_{t-p} + \varepsilon_{t} + \alpha_{1}\varepsilon_{t-1} + \dots + \alpha_{q}\varepsilon_{t-q}$$

with white noise ε_t

Lag (or shift) operator
$$L(Ly_t = y_{t-1}, L^0y_t = Iy_t = y_t, L^py_t = y_{t-p})$$

ARMA(p,q) process in operator notation

$$\theta(L)y_t = \alpha(L)\varepsilon_t$$

with operator polynomials $\theta(L)$ and $\alpha(L)$

$$\theta(L) = I - \theta_1 L - \dots - \theta_p L^p$$

$$\alpha(L) = I + \alpha_1 L + \dots + \alpha_q L^q$$

Lag Operator

Lag (or shift) operator L

- Ly_t = y_{t-1} , $L^0y_t = Iy_t = y_t$, $L^py_t = y_{t-p}$
- Algebra of polynomials in L like algebra of variables

Examples:

$$(I - \phi_1 L)(I - \phi_2 L) = I - (\phi_1 + \phi_2)L + \phi_1 \phi_2 L^2$$

$$(I - \Theta L)^{-1} = \sum_{i=0}^{\infty} \Theta^i L^i$$

MA(∞) representation of the AR(1) process

$$y_t = (I - \theta L)^{-1} \varepsilon_t$$

the infinite sum defined only (e.g., finite variance) if $|\theta| < 1$

MA(∞) representation of the ARMA(p,q) process

$$y_t = [\theta(L)]^{-1}\alpha(L)\varepsilon_t$$

similarly the AR(∞) representations; invertibility condition: restrictions on parameters

Invertibility of Lag Polynomials

Invertibility condition for lag polynomial $\theta(L) = I - \theta L$: $|\theta| < 1$ Invertibility condition for lag polynomial of order 2, $\theta(L) = I - \theta_1 L - \theta_2 L^2$

- $\theta(L) = I \theta_1 L \theta_2 L^2 = (I \phi_1 L)(I \phi_2 L)$ with $\phi_1 + \phi_2 = \theta_1$ and $-\phi_1 \phi_2 = \theta_2$
- Invertibility conditions: both $(I \phi_1 L)$ and $(I \phi_2 L)$ invertible; $|\phi_1| < 1$, $|\phi_2| < 1$

Invertibility in terms of the characteristic equation

$$\theta(z) = (1 - \phi_1 z) (1 - \phi_2 z) = 0$$

- Characteristic roots: solutions z_1 , z_2 from $(1 \phi_1 z) (1 \phi_2 z) = 0$ $z_1 = \phi_1^{-1}$, $z_2 = \phi_2^{-1}$
- Invertibility conditions: $|z_1| = |\phi_1^{-1}| > 1$, $|z_2| = |\phi_2^{-1}| > 1$ Polynomial $\theta(L)$ is not invertible if any solution z_i fulfills $|z_i| \le 1$ Can be generalized to lag polynomials of higher order

Unit Root and Invertibility

Lag polynomial of order 1: $\theta(z) = (1 - \theta z) = 0$,

- Unit root: characteristic root z = 1; implies θ = 1
- Invertibility condition $|\theta|$ < 1 is violated, AR process $Y_t = \theta Y_{t-1} + \epsilon_t$ is non-stationary

Lag polynomial of order 2

- Characteristic equation $\theta(z) = (1 \phi_1 z) (1 \phi_2 z) = 0$
- Characteristic roots $z_i = 1/\phi_i$, i = 1, 2
- Unit root: a characteristic root z_i of value 1; violates the invertibility condition $|z_1| = |\phi_1^{-1}| > 1$, $|z_2| = |\phi_2^{-1}| > 1$
- AR(2) process Y_t is non-stationary

AR(p) process: polynomial $\theta(z) = 1 - \theta_1 z - ... - \theta_p L^p$, evaluated at z = 1, is zero, given $\Sigma_i \theta_i = 1$: $\Sigma_i \theta_i = 1$ indicates a unit root

Tests for unit roots are important tools for identifying stationarity

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Types of Trend

Trend: The development of the expected value of a process over time; typically an increasing (or decreasing) pattern

Deterministic trend: a function f(t) of the time, describing the evolution of E{Y_t} over time

$$Y_t = f(t) + \varepsilon_t$$
, ε_t : white noise

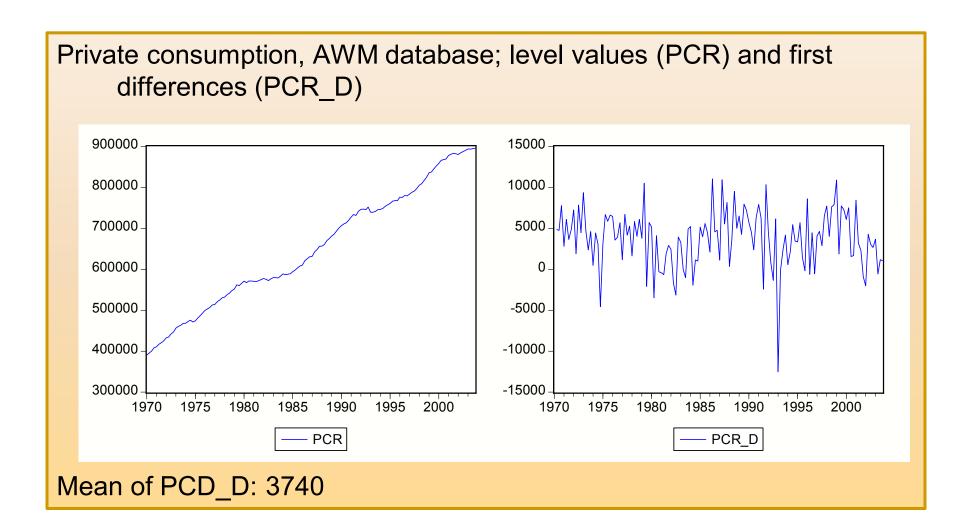
Example: $Y_t = \alpha + \beta t + \varepsilon_t$ describes a linear trend of Y; an increasing trend corresponds to $\beta > 0$

• Stochastic trend: $Y_t = \delta + Y_{t-1} + \epsilon_t$ or

$$\Delta Y_t = Y_t - Y_{t-1} = \delta + \varepsilon_t$$
, ε_t : white noise

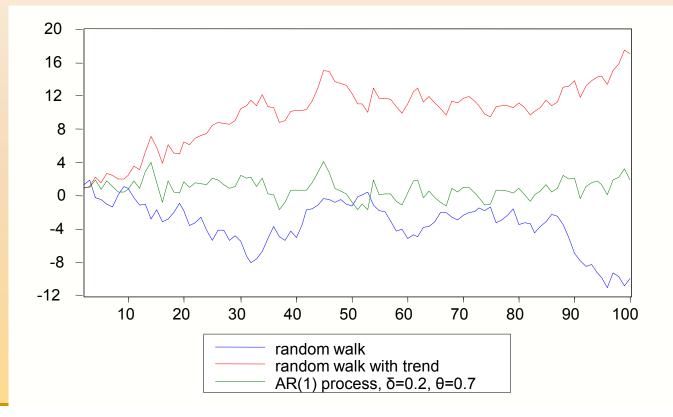
- \square AR(1) or AR(p) process with unit root
- "random walk with trend"

Example: Private Consumption



Trends: Random Walk and AR Process

Random walk: $Y_t = Y_{t-1} + \varepsilon_t$; random walk with trend: $Y_t = 0.1 + Y_{t-1} + \varepsilon_t$; AR(1) process: $Y_t = 0.2 + 0.7Y_{t-1} + \varepsilon_t$; ε_t simulated from N(0,1)



Random Walk with Trend

The random walk with trend $Y_t = \delta + Y_{t-1} + \varepsilon_t$ can be written as

$$Y_t = Y_0 + \delta t + \sum_{i \le t} \varepsilon_i$$

δ: trend parameter

Components of the process

- Deterministic growth path Y₀ + δt
- Cumulative errors Σ_{i≤t} ε_i

Properties:

- Expectation $Y_0 + \delta t$ is depending on Y_0 , i.e., on the origin (t=0)!
- $V{Y_t} = \sigma^2 t$ becomes arbitrarily large!
- Corr{ Y_t, Y_{t-k} } = $\sqrt{(1-k/t)}$
- Random walk with trend is non-stationary!

Random Walk with Trend, cont'd

From Corr $\{Y_t, Y_{t-k}\} = \sqrt{(1-k/t)}$ follows

- For fixed k, Y_t and Y_{t-k} are the stronger correlated, the larger t
- With increasing k, correlation tends to zero, but tends the slower to zero the larger t (long memory property)

Random walk vs. the AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$

- AR(1) process: ε_{t-i} has the lesser weight, the larger i
- AR(1) process similar to random walk when θ is close to one

Non-Stationarity: Consequences

AR(1) process
$$Y_t = \theta Y_{t-1} + \varepsilon_t$$

OLS estimator for θ:

$$\hat{\theta} = \frac{y_t y_{t-1}}{y_t^2}$$

- For $|\theta|$ < 1: the estimator is
 - consistent
 - asymptotically normally distributed
- For θ = 1 (unit root)
 - θ is underestimated
 - estimator not normally distributed
 - spurious regression problem

Integrated Processes

In order to cope with non-stationarity

- Trend-stationary process: the process can be transformed in a stationary process by subtracting the deterministic trend
 - \Box E.g., $Y_t = f(t) + ε_t$ with white noise $ε_t$: $Y_t f(t) = ε_t$ is stationary
- Difference-stationary process, or integrated process: stationary process can be achieved by differencing
 - $\blacksquare \quad \text{E.g., } Y_t = \delta + Y_{t-1} + \varepsilon_t, \text{ E.g., } Y_t Y_{t-1} = \delta + \varepsilon_t \text{ is stationary}$

Integrated process: stochastic process Y is called

- integrated of order one if the first difference yield a stationary process: Y ~ I(1)
- integrated of order d, if the d-fold differences yield a stationary process: $Y \sim I(d)$

I(0)- vs. I(1)-Processes

$$I(0)$$
 process, e.g., $Y_t = \delta + \varepsilon_t$

- Fluctuates around the process mean with constant variance
 - Mean-reverting
 - Limited memory

$$I(1)$$
 process e.g., $Y_t = \delta + Y_{t-1} + \varepsilon_t = Y_0 + \delta t + \sum_{i \le t} \varepsilon_i$

- Fluctuates widely
 - Infinitely long memory
 - Persistent effect of shocks

Integrated Stochastic Processes

Many economic time series show stochastic trends From the AWM Database

	Variable	d
YER	GDP, real	1
PCR	Consumption, real	1-2
PYR	Household's Disposable Income, real	1-2
PCD	Consumption Deflator	2

ARIMA(p,d,q) process: d-th differences follow an ARMA(p,q) process

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Example: Model for a Stochastic Trend

Data generation: random walk (without trend): $Y_t = Y_{t-1} + \varepsilon_t$, ε_t : white noise

- Realization of Y_t: is a non-stationary process, stochastic trend
- V{Y_t}: a multiple of t

Specified model: $Y_t = \alpha + \beta t + \varepsilon_t$

- Deterministic trend
- Constant variance
- Miss-specified model!

Consequences for OLS estimator for β

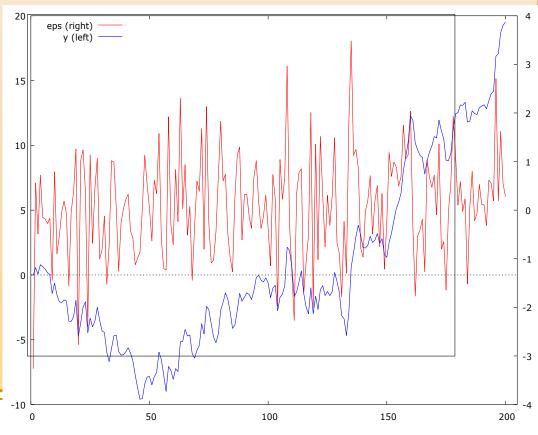
- t- and F-statistics: wrong critical limits, rejection probability too large
- R² indicates explanatory potential although Y_t a random walk without trend
- "spurious regression" or "nonsense regression"

White Noise and Random Walk

Computer-generated random numbers

- eps: white noise, i.e., N(0,1)-distributed
- Y: random walk

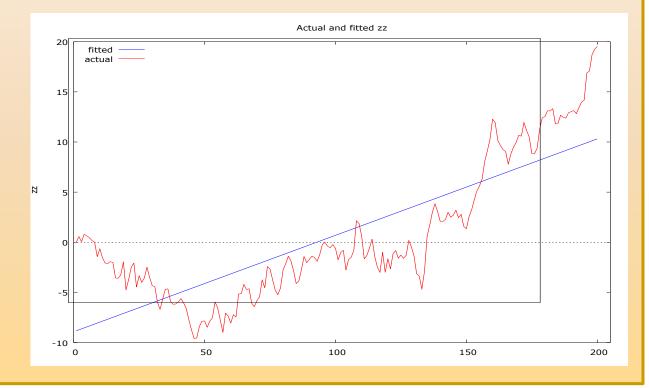
$$Y_t = Y_{t-1} + eps_t$$



Hackl, Econometrics 2, Lecture 3

Random Walk and Deterministic Trend

Fitting the deterministic trend model $Y_t = \alpha + \beta t + \epsilon_t$ to the random walk data results in -0.92 +0.096 t with t-statistic 19.77 for b, $R^2 = 0.66$, and Durbin Watson statistic 0.066



How to Model Trends?

Specification of a

- Deterministic trend, e.g., $Y_t = \alpha + \beta t + \epsilon_t$: risk of spurious regression, wrong decisions
- Stochastic trend: analysis of differences ΔY_t if a random walk, i.e., a unit root, is suspected

Consequences of spurious regression are more serious Consequences of modeling differences ΔY_t :

- Autocorrelated errors
- Consistent estimators
- Asymptotically normally distributed estimators
- HAC correction of standard errors, i.e., heteroskedasticity and autocorrelation consistent estimates of standard errors

Elimination of Trend

Random walk $Y_t = \delta + Y_{t-1} + \epsilon_t$ with white noise ϵ_t $\Delta Y_t = Y_t - Y_{t-1} = \delta + \epsilon_t$

- $\triangle Y_t$ is a stationary process
- A random walk is a difference-stationary or I(1) process Linear trend $Y_t = α + βt + ε_t$
- Subtracting the trend component α + βt provides a stationary process
- Y_t is a trend-stationary process

Contents

- Time Series
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- Unit Root Tests
- Estimation of ARMA Models

Unit Root Tests

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t

- Dickey-Fuller or DF test (Dickey & Fuller, 1979)
 Test of H₀: θ = 1 against H₁: θ < 1, i.e., H₀ states Y ~ I(1), Y is non-stationary
- KPSS test (Kwiatkowski, Phillips, Schmidt & Shin, 1992)
 Test of H₀: θ < 1 against H₁: θ = 1, i.e., H₀ states Y ~ I(0), Y is stationary
- Augmented Dickey-Fuller or ADF test extension of DF test
- Various modifications like Phillips-Perron test, Dickey-Fuller GLS test, etc.

Dickey-Fuller's Unit Root Test

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t OLS Estimator for θ :

$$\hat{\theta} = y_t y_{t-1}$$

Test statistic

$$DI = \begin{bmatrix} - \\ r_H \end{bmatrix}$$

Distribution of DF

- If |θ| < 1: approximately t(T-1)</p>
- If $\theta = 1$: Dickey & Fuller critical values

DF test for testing H_0 : $\theta = 1$ against H_1 : $\theta < 1$

 θ = 1: characteristic equation 1 – θ z = 0 has unit root

Dickey-Fuller Critical Values

Monte Carlo estimates of critical values for

 DF_0 : Dickey-Fuller test without intercept; $Y_t = \theta Y_{t-1} + \varepsilon_t$

DF: Dickey-Fuller test with intercept; $Y_t = \delta + \theta Y_{t-1} + \varepsilon_t$

 DF_{T} : Dickey-Fuller test with time trend; $Y_{t} = \delta + \gamma t + \theta Y_{t-1} + \varepsilon_{t}$

T		p = 0.01	<i>p</i> = 0.05	p = 0.10
25	DF_0	-2.66	-1.95	-1.60
	DF	-3.75	-3.00	-2.63
	DF_{\scriptscriptstyleT}	-4.38	-3.60	-3.24
100	DF_0	-2.60	-1.95	-1.61
	DF	-3.51	-2.89	-2.58
	DF_{\scriptscriptstyleT}	-4.04	-3.45	-3.15
N(0,1)		-2.33	-1.65	-1.28

Unit Root Test: The Practice

AR(1) process $Y_t = \delta + \theta Y_{t-1} + \epsilon_t$ with white noise ϵ_t can be written with $\pi = \theta$ -1 as

$$\Delta Y_t = \delta + \pi Y_{t-1} + \varepsilon_t$$

DF tests H_0 : $\pi = 0$ against H_1 : $\pi < 0$ test statistic for testing $\pi = 0$ -1 = 0 identical with DF statistic

$$DI = \tau_{A} = \tau_{A}$$

Two steps:

- 1. Regression of ΔY_t on Y_{t-1} : OLS-estimator for $\pi = \theta 1$
- 2. Test of H_0 : $\pi = 0$ against H_1 : $\pi < 0$ based on DF; critical values of Dickey & Fuller

Example: Price/Earnings Ratio

Verbeek's data set PE: annual time series data on composite stock price and earnings indices of the S&P500, 1871-2002 PE: price/earnings ratio Mean 14.6 4.0 Min 6.1 3.6 Max 36.7 3.2 St.Dev. 5.1 log(PE) 2.8 Mean 2.63 Min 1.81 2.0 Max 3.60 St.Dev. 0.33 1.6 80 90 20 30 70 90 00 50 80 log(PE)

Price/Earnings Ratio, cont'd

Fitting an AR(1) process to the log(PE) data gives:

$$\Delta Y_{t} = 0.335 - 0.125 Y_{t-1}$$

with *t*-statistic -2.569 (for Y_{t-1}) and *p*-value 0.1021

- p-value of the DF statistic (-2.569): 0.102
 - □ 1% critical value: -3.48
 - 5% critical value: -2.88
 - 10% critical value: -2.58
- H_0 : θ = 1 (non-stationarity) cannot be rejected for log(PE)

Unit root test for first differences: $\Delta\Delta Y_t = 0.008 - 0.935\Delta Y_{t-1}$, DF statistic -10.59, *p*-value 0.000 (1% critical value: -3.48)

log(PE) is I(1)

However: for sample 1871-1990: DF statistic -3.65, *p*-value 0.006; within the period 1871-1990, log(PE) is stationary

Unit Root Test: Extensions

DF test so far for a model with intercept: $\Delta Y_t = \delta + \pi Y_{t-1} + \epsilon_t$ Tests for alternative or extended models

- DF test for model without intercept: $ΔY_t = πY_{t-1} + ε_t$
- DF test for model with intercept and trend: $ΔY_t = δ + γt + πY_{t-1} + ε_t$

DF tests in all cases H_0 : $\pi = 0$ against H_1 : $\pi < 0$

Test statistic in all cases

$$DI = \begin{bmatrix} - \\ \mathfrak{r}_{H} \end{bmatrix}$$

Critical values depend on cases; cf. Table on slide 47

KPSS Test

Process $Y_t = \beta t + (r_t + \alpha) + \varepsilon_t$, with deterministic time trend βt , a random walk $r_t = r_{t-1} + u_t$ with white noise u_t with variance σ_u^2 , $r_0 = \alpha$ serving as intercept, and white noise error term ε_t

- Test of H_0 : $\sigma_u^2 = 0$, i.e., Y_t is trend stationary, or Y_t -βt is stationary, against H_1 : $\sigma_u^2 > 0$
- H_0 implies a unit moving average root in the ARMA representation of ΔY_t
- KPSS (Kwiatkowski, Phillips, Schmidt, Shin) test statistic

$$KPSS_{=}\sum$$

with $S_t = \sum_{i=1}^t e_i$ and the variance estimate s^2 of the residuals e_t from the regression $Y_t = \delta + \beta t + \epsilon_t$

- Reject H₀ for large values of KPSS
- Critical values from Monte Carlo simulations

ADF Test

Extended model according to an AR(p) process:

$$\Delta Y_{t} = \delta + \pi Y_{t-1} + \beta_{1} \Delta Y_{t-1} + \dots + \beta_{p} \Delta Y_{t-p+1} + \varepsilon_{t}$$

Example: AR(2) process $Y_t = \delta + \theta_1 Y_{t-1} + \theta_2 Y_{t-2} + \varepsilon_t$ can be written as

$$\Delta Y_{t} = \delta + (\theta_{1} + \theta_{2} - 1)Y_{t-1} - \theta_{2}\Delta Y_{t-1} + \varepsilon_{t}$$

the characteristic equation $(1 - \phi_1 L)(1 - \phi_2 L) = 0$ has roots $\theta_1 = \phi_1 + \phi_2$ and $\theta_2 = -\phi_1 \phi_2$

a unit root implies $\phi_1 = \theta_1 + \theta_2 = 1$:

Augmented DF (ADF) test

- Test of H₀: π = 0 , i.e., Y ~ I(1), against H₁: π < 0</p>
- For choice of p: information criterion, e.g, AIC
- Extensions (intercept, trend) similar to the DF-test
- Phillips-Perron test: alternative method; uses HAC-corrected standard errors

ADF-GLS Test

Variant of the Dickey–Fuller test

The variable to be tested is assumed to have

- a non-zero mean or
- a linear trend

De-meaning or de-trending

GLS procedure suggested by Elliott, Rothenberg and Stock (1996)

ADF-GLS test has higher power than the ADF test

Price/Earnings Ratio, cont'd

Extended model according to an AR(2) process gives:

```
\Delta Y_{t} = 0.366 - 0.136 Y_{t-1} + 0.152 \Delta Y_{t-1} - 0.093 \Delta Y_{t-2} with t-statistics -2.487 (Y_{t-1}), 1.667 (\Delta Y_{t-1}) and -1.007 (\Delta Y_{t-2}) and p-values 0.014, 0.098 and 0.316
```

- p-value of the DF statistic (-2.487): 0.119
 - □ 1% critical value: -3.48
 - 5% critical value: -2.88
 - □ 10% critical value: -2.58
- Non-stationarity cannot be rejected for log(PE)

Unit root test for first differences: DF statistic -7.31, *p*-value 0.000 (1% critical value: -3.48)

log(PE) is I(1)

However: for sample 1871-1990: DF statistic -3.52, p-value 0.009

Unit Root Tests in GRETL

For marked variable:

Variable > Unit root tests > Augmented Dickey-Fuller test

Performs the

- DF test (choose zero for "Lag order for ADF test") or the
- ADL test
- with or without constant, trend, squared trend
- Variable > Unit root tests > ADF-GLS test

Performs the

- DF test (choose zero for "Lag order for ADF test") or the
- ADL test
- De-meaning or de-trending using GLS
- Variable > Unit root tests > KPSS test

Performs the KPSS test with or without a trend

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ARMA Models: Application

Application of the ARMA(p,q) model in data analysis: Three steps

- 1. Model specification, i.e., choice of p, q (and d if an ARIMA model is specified)
- Parameter estimation
- 3. Diagnostic checking

Estimation of ARMA Models

The estimation methods

- OLS estimation
- ML estimation

AR models:
$$Y_{t} = \delta + \theta_{1}Y_{t-1} + \theta_{2}Y_{t-2} + ... + \theta_{p}Y_{t-p} + \varepsilon_{t}$$

- Explanatory variables are lagged values of the explained variable
- Uncorrelated with error term
- OLS estimation gives consistent estimators

MA Models: OLS Estimation

MA models

- Minimization of sum of squared deviations is not straightforward
- E.g., for an MA(1) model, $S(\mu,\alpha) = \Sigma_t[Y_t \mu \alpha \Sigma_{j=0}(-\alpha)^j (Y_{t-j-1} \mu)]^2$
 - \Box S(μ , α) is a nonlinear function of parameters
 - □ Needs Y_{t-j-1} for j=0,1,..., i.e., historical Y_s , s < 0
- Approximate solution from minimization of

$$S^*(\mu,\alpha) = \sum_{t} [Y_t - \mu - \alpha \sum_{j=0}^{t-2} (-\alpha)^j (Y_{t-j-1} - \mu)]^2$$

- Nonlinear minimization, grid search (over -1 < α < 1)
- Estimators for μ and α: consistent and asymptotically normal

ARMA models combine AR part with MA part

ML Estimation

Assumption of normally distributed ε_t

Log likelihood function, conditional on initial values

log L(
$$\alpha, \theta, \mu, \sigma^2$$
) = - [(T -1)/2] log($2\pi\sigma^2$) - ($2\sigma^2$)⁻¹ $\Sigma_t \varepsilon_t^2$

 ε_t are functions of the parameters and of the past of y

- AR(1): $ε_t = y_t θ_1 y_{t-1}$
- MA(1): $ε_t = Σ_{j=0}^{t-1} (-α)^j y_{t-j}$

Initial values: y_1 for AR, $\varepsilon_0 = 0$ for MA

- Conditional (on initial values) ML estimators: identical to OLS estimators
- Extension to exact ML estimator
- Again, estimation for AR models easier
- ARMA models combine AR part with MA part
- Approximation of MA- and ARMA-model by AR model of high order

Model Specification

Based on estimates of

- Autocorrelation function (ACF)
- Partial Autocorrelation function (PACF)

Structure of AC and PAC functions typical for AR and MA processes Example:

- MA(1) process: $\rho_0 = 1$, $\rho_1 = \alpha/(1-\alpha^2)$; $\rho_i = 0$, i = 2, 3, ...; $\theta_{kk} = \alpha^k$, k = 0, 1, ...
- AR(1) process: $\rho_k = \theta^k$, $k = 0, 1, ...; \theta_{00} = 1, \theta_{11} = \theta, \theta_{kk} = 0$ for k > 1

Empirical ACF and PACF give indications on the process underlying the time series

ARMA(p,q)-Processes

Condition for	$\frac{AR(\boldsymbol{p})}{\theta(L)Y_{t}} = \varepsilon_{t}$	$\mathbf{MA}(q)$ $Y_{t} = \alpha(L) \ \varepsilon_{t}$	ARMA(p , q) θ(L) Y_t =α(L) $ε_t$
Stationarity	roots z_i of $\theta(z)=0$: $ z_i > 1$	always stationary	roots z_i of $\theta(z)=0$: $ z_i > 1$
Invertibility	always invertible	roots z_i of $\alpha(z)=0: z_i > 1$	roots z_i of $\alpha(z)=0$: $ z_i > 1$
AC function	damped, infinite	$\rho_k = 0$ for $k > q$	damped, infinite
PAC function	$\theta_{kk} = 0 \text{ for } k > p$	damped, infinite	damped, infinite

Estimated AC and PAC Functions

Estimation of the AC and PAC functions

AC ρ_k :

$$\eta_k = \frac{1}{2} y_t \underline{y} \underbrace{y_t \underline{y}}_{t} \underline{y}^{k} \underline{y}^{k}$$

PAC θ_{kk} : coefficient of Y_{t-k} in regression of Y_t on Y_{t-1} , ..., Y_{t-k}

MA(q) process: standard errors for r_k , k > q, from

$$\sqrt{T(r_k - \rho_k)} \rightarrow N(0, v_k)$$

with $v_k = 1 + 2\rho_1^2 + ... + 2\rho_k^2$

test of H_0 : $\rho_1 = 0$, i.e., model is MA(0): compare $\sqrt{T}r_1$ with critical value from N(0,1), etc.

AR(p) process: test of H_0 : $\rho_k = 0$ for k > p based on asymptotic distribution

Diagnostic Checking

ARMA(p,q): Adequacy of choices p and q

Analysis of residuals from fitted model:

- Correct specification: residuals are realizations of white noise
- Box-Ljung Portmanteau test: for a ARMA(p,q) process

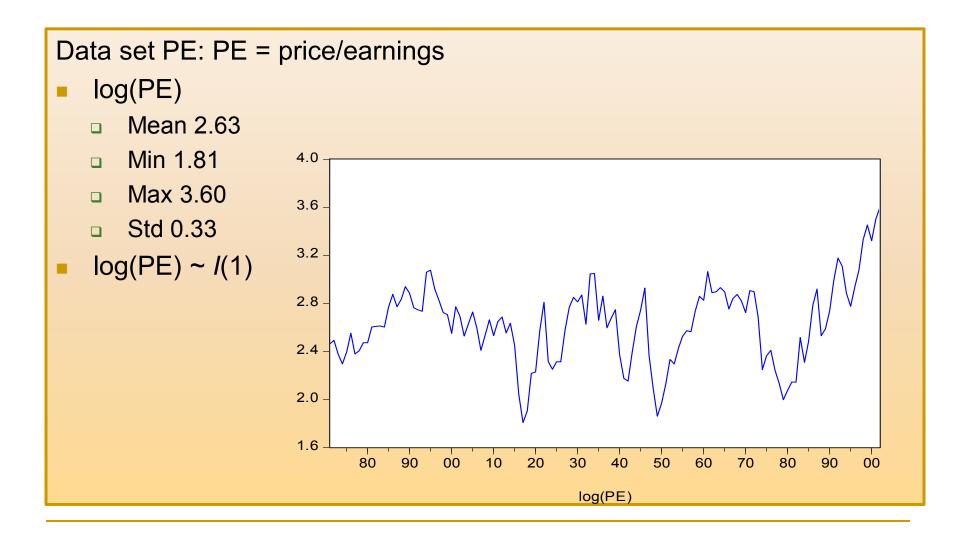
$$Q_{k} = T(T_{+}2) \sum_{k=1}^{K} T_{k}^{1} k^{2}$$

follows the Chi-squared distribution with K-p-q df

Overfitting

- Starting point: a model chosen based on sample AC and PAC functions
- Comparison with a model with further parameters: test significance of the additional parameters

Example: Price/Earnings Ratio



PE Ratio: AC and PAC Function

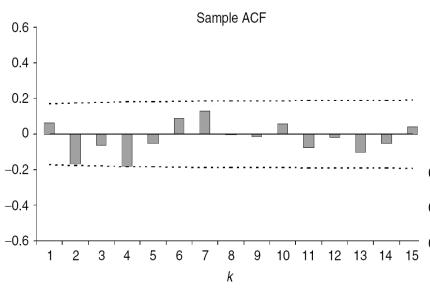


Figure 8.7 Sample autocorrelation function of log(P/E)

Sample ACF and PACF of log(PE_t), the relative change of PE_t,



- ACF: *k* = 4
- PACF: k = 2, 4

possibly MA(4) (ACF_k=0 if k>4) or AR(4)

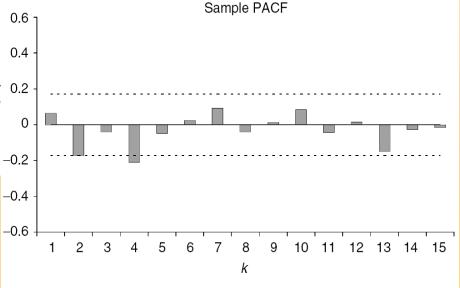


Figure 8.8 Sample partial autocorrelation function of log(P/E)

PE Ratio: MA (4) Model

MA(4) model for differences $\Delta y_t = \Delta \log(PE_t) = \log(PE_t) - \log(PE_{t-1})$, LOGPE = $\log(PE)$

Function evaluations: 37 Evaluations of gradient: 11

Model 2: ARMA, using observations 1872-2002 (T = 131)

Estimated using Kalman filter (exact ML)

Dependent variable: d_LOGPE Standard errors based on Hessian

	coefficient	std. error	t-ratio	p-value	
const	0,00804276	0,0104120	0,7725	0,4398	
theta_1	0,0478900	0,0864653	0,5539	0,5797	
theta_2	-0,187566	0,0913502	-2,053	0,0400 **	
theta_3	-0,0400834	0,0819391	-0,4892	0,6247	
theta_4	-0,146218	0,0915800	-1,597	0,1104	
Mean dependent var		0,008716	S.D. dependent var		0,181506
Mean of innovations		-0,000308	S.D. of innovations		0,174545
Log-likelihood		42,69439	Akaike criterion		-73,38877
Schwarz criterion		-56,13759	Hannan-Quinn		-66,37884

PE Ratio: AR(4) Model

```
AR(4) model for differences \Delta y_t = \Delta \log(PE_t) = \log(PE_t) - \log(PE_{t-1})
                       Function evaluations: 36
                       Evaluations of gradient: 9
                       Model 3: ARMA, using observations 1872-2002 (T = 131)
                       Estimated using Kalman filter (exact ML)
                       Dependent variable: d LOGPE
                       Standard errors based on Hessian
                                   coefficient
                                                std. error
                                                            t-ratio
                                                                         p-value
                                 0,00842210
                                                0,0111324
                                                            0.7565
                                                                         0,4493
                        const
                        phi 1
                                0.0601061
                                                0,0851737
                                                            0,7057
                                                                         0,4804
                                                0,0856482
                                                            -2,369
                                                                         0,0178 **
                        phi 2
                                -0,202907
                        phi 3
                                -0,0228251
                                                0.0853236
                                                            -0,2675
                                                                         0,7891
                                                                         0,0151 **
                        phi 4
                                -0,206655
                                                0,0850843
                                                            -2,429
                       Mean dependent var
                                                0,008716
                                                            S.D. dependent var
                                                                                      0,181506
                       Mean of innovations
                                                -0,000315
                                                            S.D. of innovations
                                                                                      0,173633
                       Log-likelihood
                                                43,35448
                                                            Akaike criterion
                                                                                      -74,70896
                       Schwarz criterion
                                                -57,45778
                                                            Hannan-Quinn
                                                                                      -67,69903
```

PE Ratio: Various Models

Diagnostics for various competing models: $\Delta y_t = \log(PE_t) - \log(PE_{t-1})$ Best fit for

BIC: MA(2) model Δy_t = 0.008 + e_t – 0.250 e_{t-2}

AIC: AR(2,4) model $\Delta y_t = 0.008 - 0.202 \Delta y_{t-2} - 0.211 \Delta y_{t-4} + e_t$

Model	Lags	AIC	BIC	Q ₁₂	<i>p</i> -value
MA(4)	1-4	-73.389	-56.138	5.03	0.957
AR(4)	1-4	-74.709	-57.458	3.74	0.988
MA	2, 4	-76.940	-65.440	5.48	0.940
AR	2, 4	-78.057	-66.556	4.05	0.982
MA	2	-76.072	-67.447	9.30	0.677
AR	2	-73.994	-65.368	12.12	0.436

Time Series Models in GRETL

```
Variable > Unit root tests > (a) Augmented Dickey-
Fuller test, (b) ADF-GLS test, (c) KPSS test
```

- a) DF test or ADF test with or without constant, trend and squared trend
- DF test or ADF test with or without trend, GLS estimation for demeaning and de-trending
- c) KPSS (Kwiatkowski, Phillips, Schmidt, Shin) test

```
Model > Time Series > ARIMA
```

Estimates an ARMA model, with or without exogenous regressors

Your Homework

- 1. Use Greene's data set GREENE18_1 (Corporate bond yields, 1990:01 to 1994:12) and answer the following questions for the variable *YIELD* (yield on Moody's Aaa rated corporate bond).
 - a) Using the model-statement "Ordinary Least Squares ..." in Gretl, (i) regress ΔΥΙΕLD on ΥΙΕLD₋₁ and an intercept and compute the DF test statistics for a unit root. What do you conclude (ii) about the presence of a unit root, about stationarity of ΥΙΕLD?
 - b) Produce a time series plot of *YIELD*. Interpret the graph in view of the results of a).
 - c) Using Gretl, conduct ADF tests including (i) without and (ii) with a linear trend, and (iii) with seasonal dummies. What do you conclude about the presence of a unit root? Compare the results with those of a).
 - d) Transform *YIELD* into its first differences *d_YIELD*. Repeat c) for the differences. What do you conclude?

Your Homework

- e) Determine the sample ACF and PACF for *YIELD*. What orders of the ARMA model for *YIELD* is suggested by these graphs?
- f) Estimate (i) an AR(1)- and (ii) an AR(2)-model for *YIELD*; (ii) test for autocorrelation in the residuals of the two models. What do you conclude?
- 2. For the random walk with trend $Y_t = \delta + Y_{t-1} + \varepsilon_t$, show that (a) $V\{Y_t\} = \sigma^2 t$, and (b) $Corr\{Y_t, Y_{t-k}\} = \sqrt{(1-k/t)}$.
- 3. For the AR(1) process $Y_t = \theta Y_{t-1} + \varepsilon_t$ with white noise ε_t , show that (a) the ACF is $\rho_k = \theta^k$, k = 0, 1, ..., and that (b) the PACF is $\theta_{00} = 1$, $\theta_{11} = \theta$, $\theta_{kk} = 0$ for k > 1.